

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination ADACHI ET AL.	
		Examiner SHENG HAN	Art Unit 1793	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-4,692,228	09-1987	Twardowski, Zbigniew	205/563
*	B US-2006/0130610	06-2006	Ward-Close et al.	075/345
*	C US-3,764,500	10-1973	Gibson	210/609
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

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N					
O					
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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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